

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/602,245	<b>Applicant(s)/Patent under Reexamination</b> CHAN ET AL.
	<b>Examiner</b> Janice A. Mooneyham	<b>Art Unit</b> 3629

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner